

60V N-Channel Power MOSFET

• **General Description**

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

• **Features**

- Low $R_{DS(ON)}$ to minimize conductive loss
- High GOX reliability
- Low Thermal resistance

• **Application**

- BLDC Motor driver
- DC-DC
- Battery protection

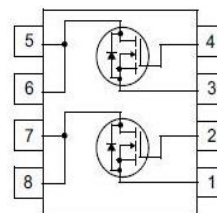
• **Ordering Information:**

Part NO.	ZMD68601S
Marking	ZMD68601
Packing Information	REEL TAPE
Basic ordering unit (pcs)	4000

• **Absolute Maximum Ratings** ($T_C=25^\circ\text{C}$)

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V_{DS}	$25^\circ\text{C} \leq T_J \leq 150^\circ\text{C}$	60	V
Gate-Source Voltage	V_{GS}		± 20	V
Continuous Drain Current	I_D	$T_C=25^\circ\text{C}$	6.5	A
	I_D	$T_C=75^\circ\text{C}$	6	A
	I_D	$T_C=100^\circ\text{C}$	5	A
Pulsed Drain Current	I_{DM}	Pulsed; $t_p \leq 10 \mu\text{s}$; $T_{mb} = 25^\circ\text{C}$;	26	A
Total Power Dissipation	P_D	$T_C=25^\circ\text{C}$	4	W
Total Power Dissipation	P_D	$T_A=25^\circ\text{C}$	0.7	W
Operating Junction Temperature	T_J		-55 to +150	$^\circ\text{C}$
Storage Temperature	T_{STG}		-55 to +150	$^\circ\text{C}$
Single Pulse Avalanche Energy	E_{AS}	$L=0.1\text{mH}$, $V_{GS}=10\text{V}$, $R_g=25\Omega$,	27	mJ
		$L=0.5\text{mH}$, $V_{GS}=10\text{V}$, $R_g=25\Omega$,	49	mJ
ESD Level (HBM)	CLASS 1B			

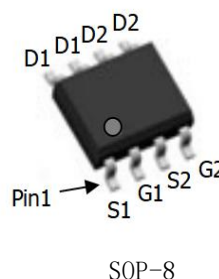
• **Product Summary**



$$V_{DS} = 60\text{V}$$

$$R_{DS(ON)} = 23\text{m}\Omega$$

$$I_D = 6.5\text{A}$$



•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R_{thJC}		-	34	°C/W
Thermal resistance, junction-ambient ^①	R_{thJA}		-	180	°C/W
Soldering temperature	T_{sold}		-	260	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	60			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	1.3	1.7	2.5	V
Drain-Source Leakage Current	I_{DSS}	$V_{GS}=0V, V_{DS}=60V$			1.0	μA
Gate- Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$			100	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=8A$		23	27	m Ω
		$V_{GS}=4.5V, I_D=6A$		27	35	m Ω
Forward Transconductance	g_{FS}	$V_{GS}=5V, I_{SD}=5A$		10		s
Diode Forward Voltage	V_{FSD}	$V_{GS}=0V, I_{SD}=8A$			1.3	V

•Dynamic characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C_{iss}	$f=1MHz, V_{DS}=25V$	-	1850	-	pF
Output capacitance	C_{oss}		-	121	-	
Reverse transfer capacitance	C_{rss}		-	91	-	
Gate Resistance	R_g	$f=1MHz$	-	1.8		Ω
Total gate charge	Q_g	$V_{DD}=15V, I_D=6A, V_{GS}=10V$	-	26	-	nC
Gate - Source charge	Q_{gs}		-	5.8	-	
Gate - Drain charge	Q_{gd}		-	5.9	-	
Turn-ON Delay time	$t_{D(on)}$	$V_{GS}=10V, V_{DS}=15V, R_G=3.3\Omega, I_D=6A$	-	18	-	ns
Turn-ON Rise time	t_r		-	9	-	ns
Turn-Off Delay time	$t_{D(off)}$		-	26	-	ns
Turn-Off Fall time	t_f		-	6	-	ns

Fig.1 Gate-Charge Characteristics

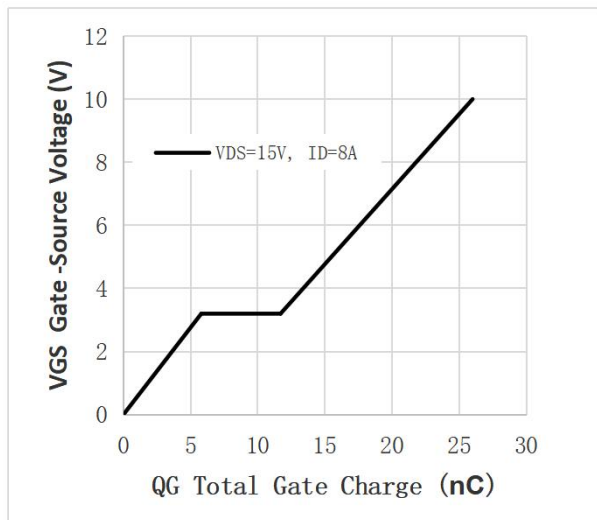


Fig.2 Capacitance Characteristics

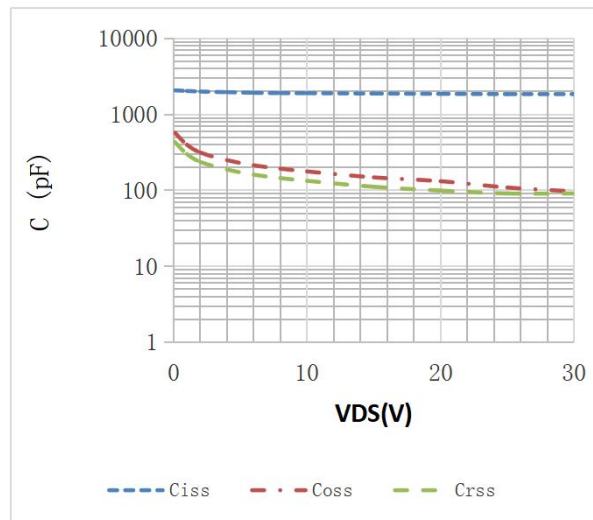


Fig.3 Power Dissipation

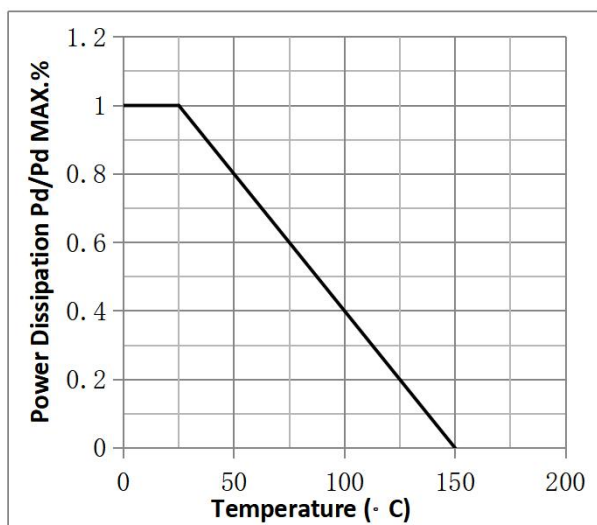


Fig.4 Typical output Characteristics

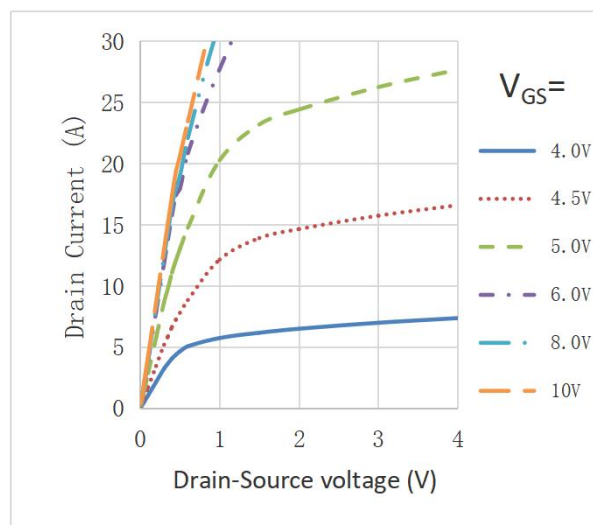


Fig.5 Threshold Voltage V.S Junction Temperature

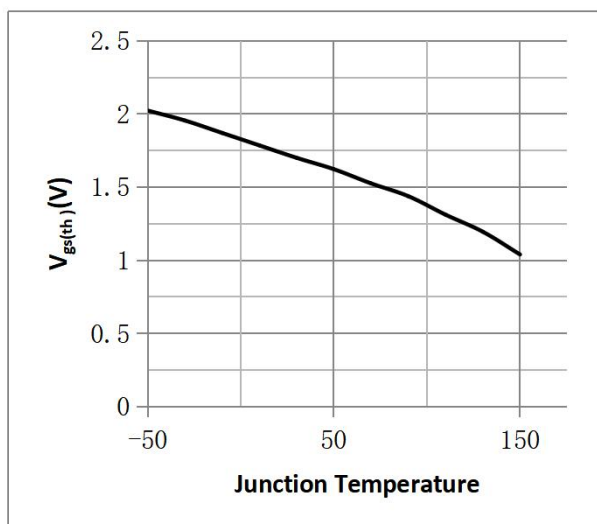


Fig.6 Resistance V.S Drain Current

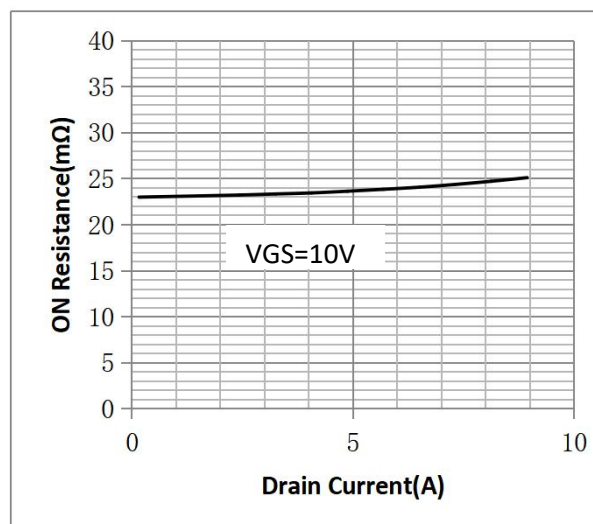


Fig.7 On-Resistance VS Gate Source Voltage

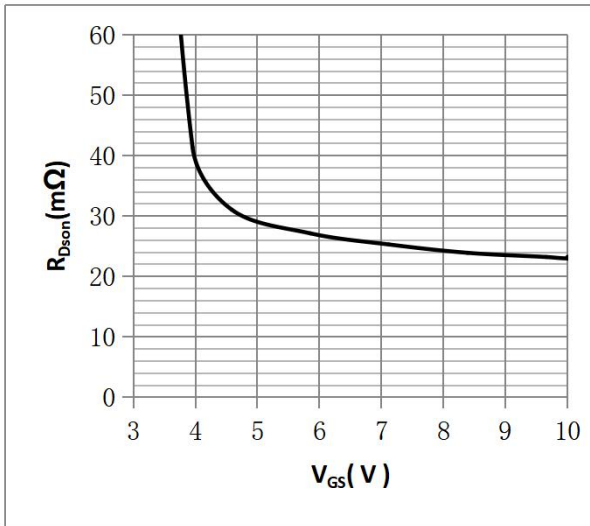


Fig.8 On-Resistance V.S Junction Temperature

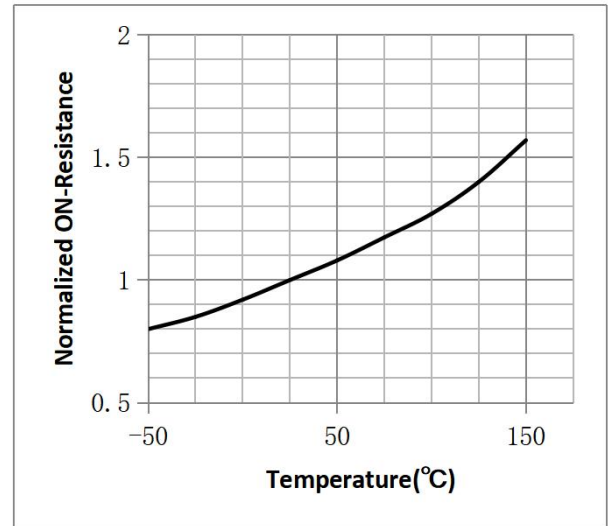


Figure 9. Diode Forward Voltage vs. Current

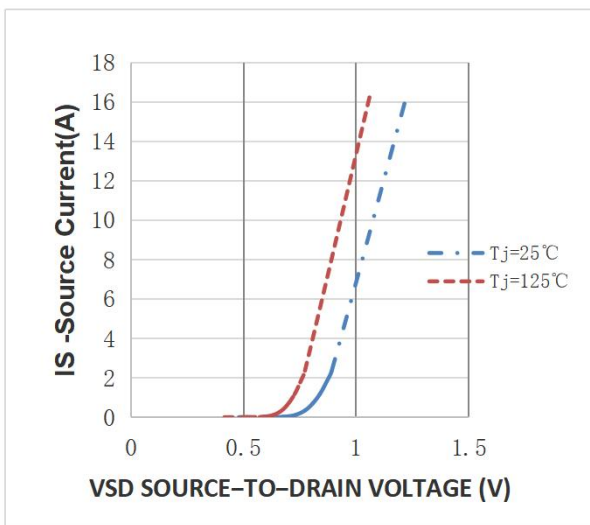


Figure 10. Transfer Characteristics

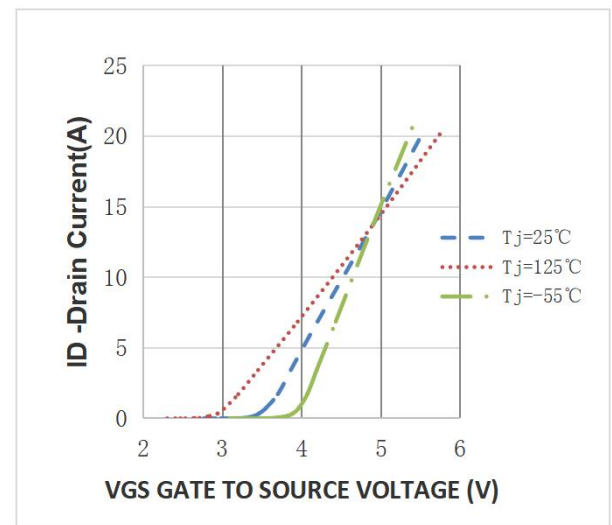


Fig.11 SOA Maximum Safe Operating Area

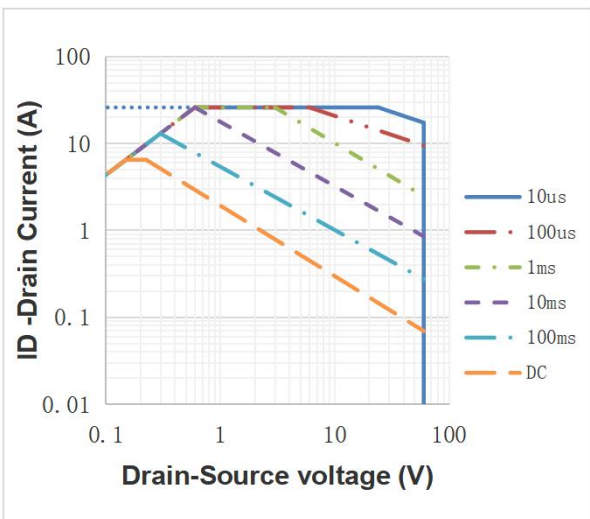
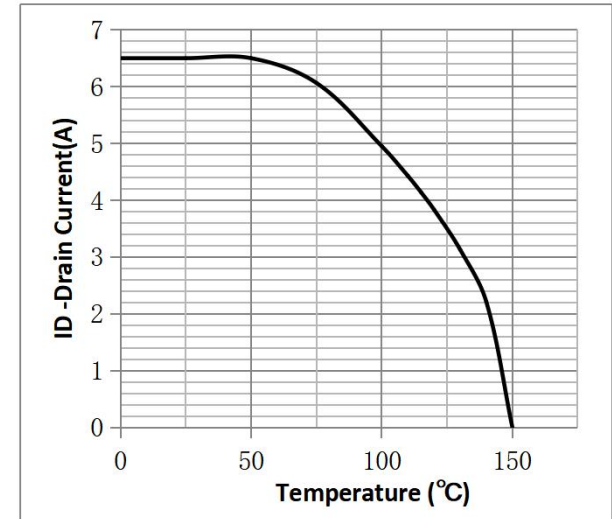
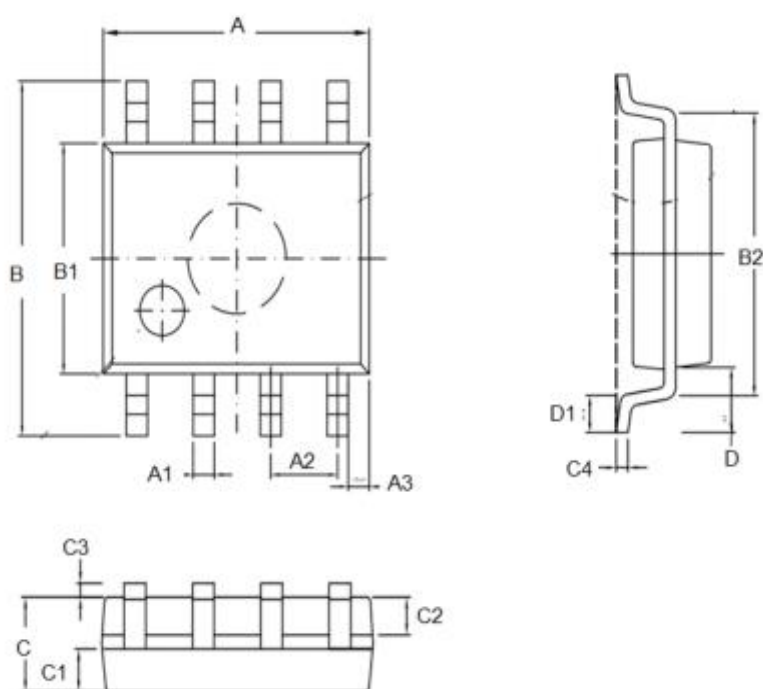


Fig.12 I_D vs. Case Temperature^②



•SOP-8 Package Outline

SYMBOL	min	TYP	max	SYMBOL	min		max
A	4.8		5.25	C	1.3		1.75
A1	0.37		0.49	C1	0.55		0.75
A2		1.27		C2	0.55		0.65
A3		0.41		C3	0.05		0.2
B	5.8		6.2	C4	0.1	0.2	0.23
B1	3.8		4.1	D		1.05	
B2		5		D1	0.4		0.62



Note:

- ① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ② Practically the current will be limited by PCB, thermal design and operating temperature. $V_{GS}=10V$.

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Revision History

Version	Date	Change
A	2020. 6. 3	NEW
B	2023. 12. 7	1. Correct Dynamic characteristics. 2. Modify Characteristics curve.